

February 1998

### Features

- **Wide Analog-Input-Voltage Range** . . . . . 0V to 10V
- **Low "ON" Resistance**
  - 45Ω (Typ) . . . . . V<sub>CC</sub> = 4.5V
  - 35Ω (Typ) . . . . . V<sub>CC</sub> = 6V
  - 30Ω (Typ) . . . . . 1fV<sub>CC</sub> = 9V
- **Fast Switching and Propagation Delay Times**
- **Low "OFF" Leakage Current**
- **Built-In "Break-Before-Make" Switching**
- **Suitable for Sample and Hold Applications**
- **Wide Operating Temperature Range** . . . -55°C to 125°C
- **HC Types**
  - 2V to 10V Operation
  - High Noise Immunity: N<sub>IL</sub> = 30%, N<sub>IH</sub> = 30% of V<sub>CC</sub> at V<sub>CC</sub> = 5V

### Description

The Harris CD74HC4016 contains four independent digitally controlled analog switches that use silicon-gate CMOS technology to achieve operating speeds similar to LSTTL with the low power consumption of standard CMOS integrated circuits.

Each switch has two input/output terminals (nY, nZ) and an active high enable input (nE). Current through the switch will not cause additional V<sub>CC</sub> current provided the analog voltage is maintained between V<sub>CC</sub> and GND.

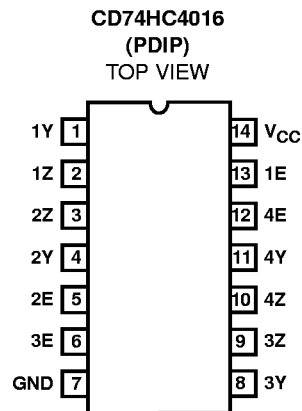
### Ordering Information

PART NUMBER	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
CD74HC4016E	-55 to 125	14 Ld PDIP	E14.3
CD74HC4016E	-55 to 125	14 Ld SOIC	M14.15

#### NOTES:

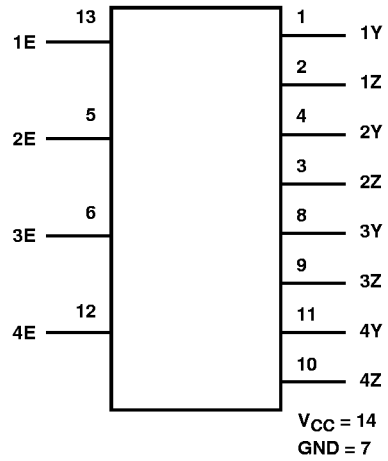
1. When ordering, use the entire part number. Add the suffix 96 to obtain the variant in the tape and reel.
2. Wafer and die for this part number is available which meets all electrical specifications. Please contact your local sales office or Harris customer service for ordering information.

### Pinout



# CD74HC4016

## Functional Diagram



### TRUTH TABLE

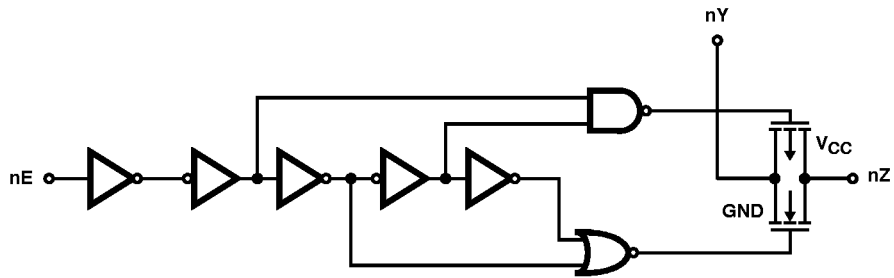
INPUT nE	SWITCH
L	OFF
H	ON

NOTE:

H = High Level Voltage

L = Low Level Voltage

## Logic Diagram



# CD74HC4016

## Absolute Maximum Ratings

DC Supply Voltage, $V_{CC}$ .....	-0.5V to 7V
DC Input Diode Current, $I_{IK}$	
For $V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$ .....	$\pm 20mA$
DC Drain Current, per Output, $I_O$	
For $-0.5V < V_O < V_{CC} + 0.5V$ .....	$\pm 25mA$
DC Output Diode Current, $I_{OK}$	
For $V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$ .....	$\pm 20mA$
DC Output Source or Sink Current per Output Pin, $I_O$	
For $V_O > -0.5V$ or $V_O < V_{CC} + 0.5V$ .....	$\pm 25mA$
DC $V_{CC}$ or Ground Current, $I_{CC}$ .....	$\pm 50mA$

## Thermal Information

Thermal Resistance (Typical, Note 3)	$\theta_{JA}$ ( $^{\circ}C/W$ )
PDIP Package .....	90
Maximum Junction Temperature (Plastic Package) .....	150 $^{\circ}C$
Maximum Storage Temperature Range .....	-65 $^{\circ}C$ to 150 $^{\circ}C$
Maximum Lead Temperature (Soldering 10s) .....	300 $^{\circ}C$

## Operating Conditions

Temperature Range, $T_A$ .....	-55 $^{\circ}C$ to 125 $^{\circ}C$
Supply Voltage Range, $V_{CC}$	
HC Types .....	2V to 10V
DC Input or Output Voltage, $V_I, V_O$ .....	0V to $V_{CC}$
Input Rise and Fall Time	
2V .....	1000ns (Max)
4.5V .....	500ns (Max)
6V .....	400ns (Max)
9V .....	250ns (Max)

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

- $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.

## DC Electrical Specifications

PARAMETER	SYMBOL	TEST CONDITIONS			25 $^{\circ}C$			-40 $^{\circ}C$ TO 85 $^{\circ}C$		-55 $^{\circ}C$ TO 125 $^{\circ}C$		UNITS
		$V_I$ (V)	$V_{IS}$ (V)	$V_{CC}$ (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
<b>HC TYPES</b>												
High Level Input Voltage	$V_{IH}$	-	-	2	1.5	-	-	1.5	-	1.5	-	V
				4.5	3.15	-	-	3.15	-	3.15	-	V
				6	4.2	-	-	4.2	-	4.2	-	V
Low Level Input Voltage	$V_{IL}$	-	-	2	-	-	0.5	-	0.5	-	0.5	V
				4.5	-	-	1.35	-	1.35	-	1.35	V
				6	-	-	1.8	-	1.8	-	1.8	V
"ON" Resistance $I_O = 1mA$	$R_{ON}$	$V_{IH}$ or $V_{IL}$	$V_{CC}$ or GND	4.5	-	45	180	-	225	-	270	$\Omega$
				6	-	35	160	-	200	-	240	$\Omega$
				9	-	30	135	-	170	-	205	$\Omega$
				4.5	-	85	320	-	400	-	480	$\Omega$
				6	-	55	240	-	300	-	360	$\Omega$
				9	-	35	170	-	215	-	255	$\Omega$
Maximum "ON" Resistance Between Any Two Switches	$\Delta R_{ON}$	$V_{IL}$ or $V_{IH}$	$V_{CC}$ or GND	4.5	-	10	-	-	-	-	-	$\Omega$
				6	-	8.5	-	-	-	-	-	$\Omega$
Switch Off Leakage Current	$I_{IZ}$	$E_n =$ GND	$V_{CC}$ or GND	6	-	-	$\pm 0.1$	-	$\pm 1$	-	$\pm 1$	$\mu A$
				10	-	-	$\pm 0.1$	-	$\pm 1$	-	$\pm 1$	$\mu A$
Logic Input Leakage Current	$I_I$	$V_{CC}$ or GND	-	6	-	-	$\pm 0.1$	-	$\pm 1$	-	$\pm 1$	$\mu A$

# CD74HC4016

## DC Electrical Specifications (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS			25°C			-40°C TO 85°C		-55°C TO 125°C		UNITS
		V <sub>I</sub> (V)	V <sub>IS</sub> (V)	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
Quiescent Device Current I <sub>O</sub> = 0mA	I <sub>CC</sub>	V <sub>CC</sub> or GND	V <sub>CC</sub> or GND	6	-	-	2	-	20	-	40	μA
				10	-	-	16	-	160	-	320	μA

NOTE: For dual-supply systems theoretical worst case (V<sub>I</sub> = 2.4V, V<sub>CC</sub> = 5.5V) specification is 1.8mA.

## Switching Specifications Input t<sub>r</sub>, t<sub>f</sub> = 6ns

PARAMETER	SYMBOL	TEST CONDITIONS	V <sub>CC</sub> (V)	25°C			-40°C TO 85°C		-55°C TO 125°C		UNITS	
				MIN	TYP	MAX	MIN	MAX	MIN	MAX		
<b>HC TYPES</b>												
Propagation Delay, Switch In to Switch Out	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	60	-	75	-	90	ns	
			4.5	-	-	12	-	15	-	18	ns	
		C <sub>L</sub> = 15pF	5	-	4	-	-	-	-	-	-	ns
			C <sub>L</sub> = 50pF	6	-	-	10	-	13	-	15	ns
				9	-	-	8	-	10	-	12	ns
Propagation Delay, Switch Turn-On En to Out	t <sub>PZH</sub> , t <sub>PZL</sub>	C <sub>L</sub> = 50pF	2	-	-	190	-	240	-	285	ns	
			4.5	-	-	38	-	48	-	57	ns	
		C <sub>L</sub> = 15pF	5	-	16	-	-	-	-	-	-	ns
			C <sub>L</sub> = 50pF	6	-	-	32	-	41	-	48	ns
				9	-	-	28	-	35	-	42	ns
Propagation Delay, Switch Turn-Off En to Out	t <sub>PHZ</sub> , t <sub>PLZ</sub>	C <sub>L</sub> = 50pF	2	-	-	145	-	180	-	220	ns	
			4.5	-	-	29	-	36	-	44	ns	
		C <sub>L</sub> = 15pF	5	-	12	-	-	-	-	-	-	ns
			C <sub>L</sub> = 50pF	6	-	-	25	-	31	-	38	ns
				9	-	-	22	-	28	-	33	ns
Input Capacitance	C <sub>I</sub>	-	-	-	-	10	-	10	-	10	pF	
Power Dissipation Capacitance (Notes 4, 5)	C <sub>PD</sub>	-	5	-	12	-	-	-	-	-	pF	

**NOTES:**

- C<sub>PD</sub> is used to determine the dynamic power consumption, per package.
- $P_D = C_{PD} V_{CC}^2 f_i + \sum (C_L + C_S) V_{CC}^2 f_o$  where f<sub>i</sub> = input frequency, f<sub>o</sub> = output frequency, C<sub>L</sub> = output load capacitance, C<sub>S</sub> = switch capacitance, V<sub>CC</sub> = supply voltage.

## Analog Channel Specifications T<sub>A</sub> = 25°C

PARAMETER	TEST CONDITIONS	V <sub>CC</sub> (V)	CD74HC4016	UNITS
Switch Frequency Response Bandwidth at -3dB Figure 3	Figure 6, Notes 6, 7	4.5	>200	MHz
Crosstalk Between Any Two Switches, Figure 4	Figure 5, Notes 7, 8	4.5	TBE	dB
Total Harmonic Distortion	1kHz, V <sub>IS</sub> = 4V <sub>P-P</sub> Figure 7	4, 5	0.078	%
	1kHz, V <sub>IS</sub> = 8V <sub>P-P</sub> Figure 7	9	0.018	%

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## Analog Channel Specifications $T_A = 25^\circ\text{C}$ (Continued)

PARAMETER	TEST CONDITIONS	$V_{CC}$ (V)	CD74HC4016	UNITS
Control to Switch Feedthrough Noise	Figure 8	4.5	TBE	mV
		9	TBE	mV
Switch "OFF" Signal Feedthrough, Figure 4	Figure 9, Notes 7, 8	4.5	-62	dB
Switch Input Capacitance, $C_S$		-	5	pF

**NOTES:**

6. Adjust input level for 0dBm at output,  $f = 1\text{MHz}$ .
7.  $V_{IS}$  is centered at  $V_{CC}/2$ .
8. Adjust input for 0dBm at  $V_{IS}$ .

## Typical Performance Curves

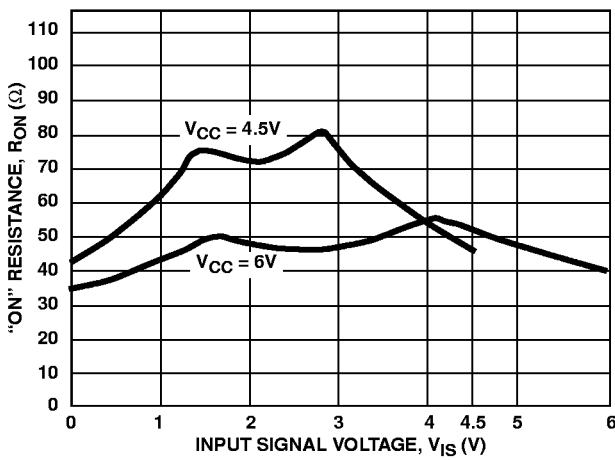


FIGURE 1. TYPICAL "ON" RESISTANCE vs INPUT SIGNAL VOLTAGE

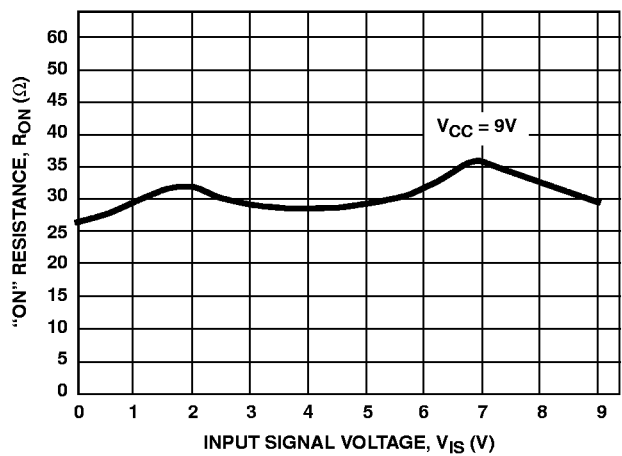


FIGURE 2. TYPICAL "ON" RESISTANCE vs INPUT SIGNAL VOLTAGE

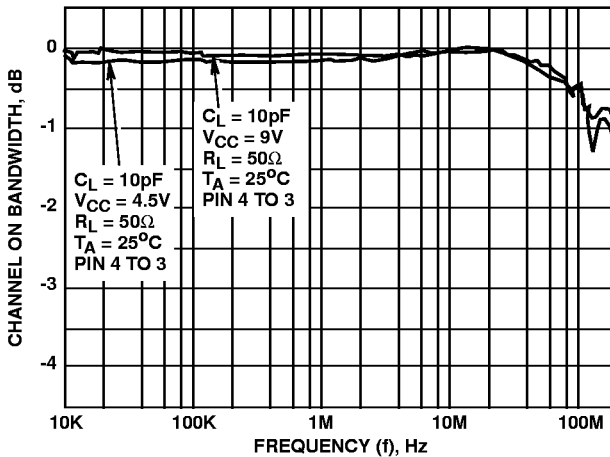


FIGURE 3. SWITCH FREQUENCY RESPONSE

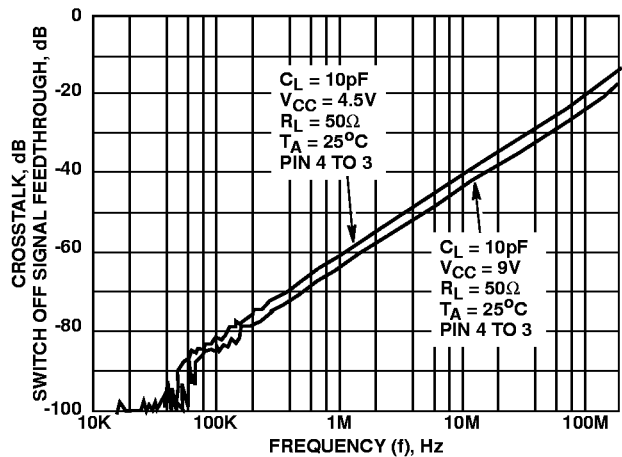


FIGURE 4. SWITCH-OFF SIGNAL FEEDTHROUGH AND CROSSTALK vs FREQUENCY

Analog Test Circuits

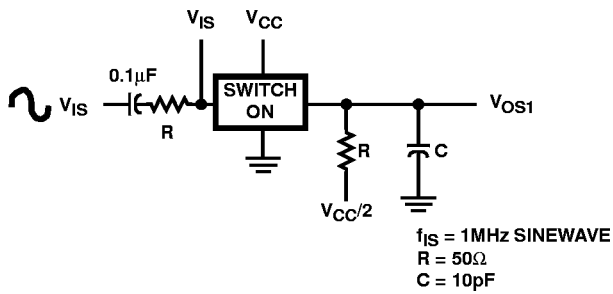


FIGURE 5. CROSSTALK BETWEEN TWO SWITCHES TEST CIRCUIT

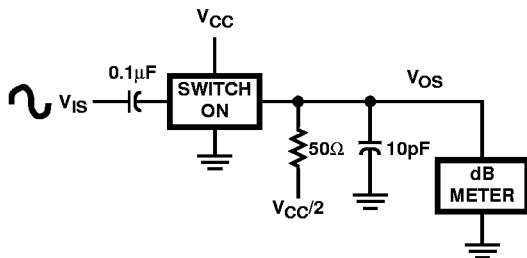
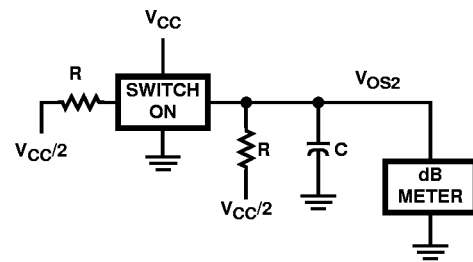


FIGURE 7. TOTAL HARMONIC DISTORTION TEST CIRCUIT

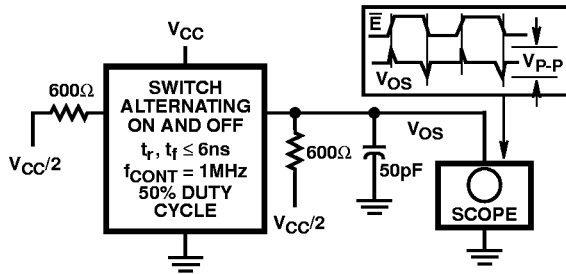


FIGURE 8. CONTROL-TO-SWITCH FEEDTHROUGH NOISE TEST CIRCUIT

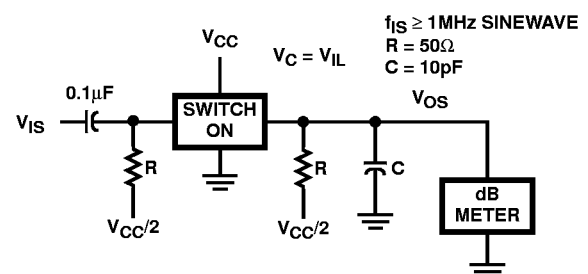


FIGURE 9. SWITCH OFF SIGNAL FEEDTHROUGH

Test Circuits and Waveforms

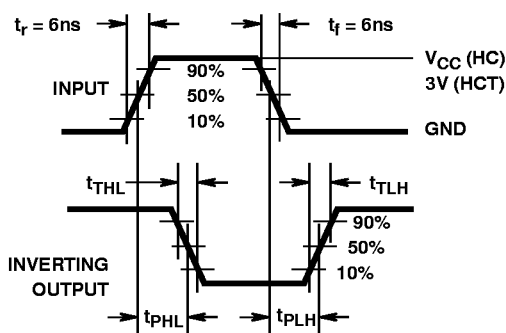


FIGURE 10. HC/HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

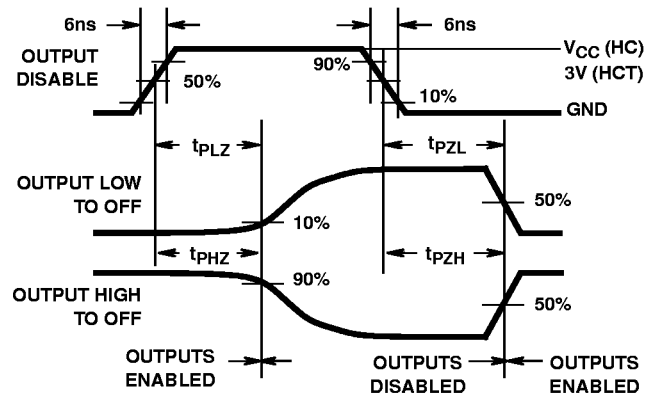


FIGURE 11. SWITCH TURN-ON AND TURN OFF PROPAGATION DELAY TIMES